

**Notice of References Cited**

Application/Control No.

10/051,185

Applicant(s)/Patent Under

Reexamination

ONO ET AL.

Examiner

Thoi V Duong

Art Unit

2871

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6417898 B1	07-2002	Izumi	349/73
	B	US-5781261	07-1998	Ohta et al.	349/111
	C	US-6466281 B1	10-2002	Huang et al.	349/44
	D	US-6271902 B1	08-2001	Ogura et al.	349/106
	E	US-6330043	12-2001	Kikkawa et al.	349/43
	F	US-6414732 B1	07-2002	Matsumoto et al.	349/106
	G	US-5850271	12-1998	Kim et al.	349/111
	H	US-6445432	09-2002	Yamamoto et al.	349/106
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.